

# 4096MB DDR3 – SDRAM RDIMM

240 Pin registered DIMM

SGP04G72D1BD2MT-CCRT

4096MB PC3-10600 in FBGA Technology

RoHS compliant

## Options:

- |                                 |                               |
|---------------------------------|-------------------------------|
| ▪ Data Rate / Latency           | Marking                       |
| DDR3 1333 MT/s CL9              | -CC                           |
| DDR3 1066 MT/s CL7              | -BB                           |
|                                 |                               |
| ▪ Module Density                |                               |
| 4096MB with 18 dies and 2 ranks |                               |
|                                 |                               |
| ▪ Standard Grade                | (T <sub>A</sub> ) 0°C to 70°C |
|                                 | (T <sub>C</sub> ) 0°C to 85°C |

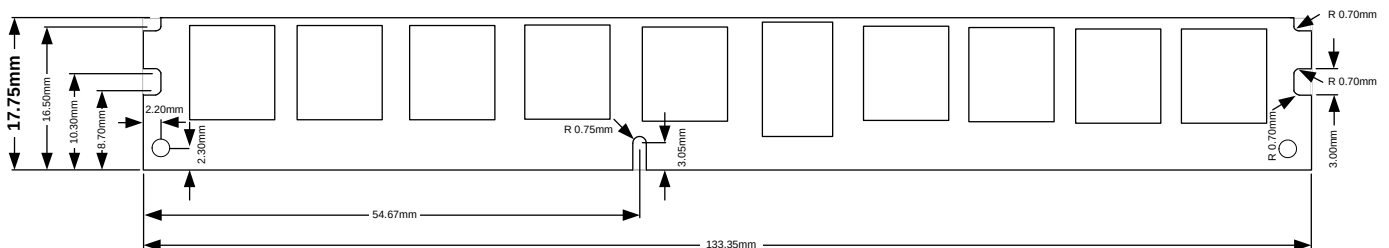
## Environmental Requirements:

- Operating temperature (ambient)  
Standard Grade 0°C to 70°C
- Operating Humidity  
10% to 90% relative humidity, non condensing
- Operating Pressure  
105 to 69 kPa (up to 10000 ft.)
- Storage Temperature  
-55°C to 100°C
- Storage Humidity  
5% to 95% relative humidity, non condensing
- Storage Pressure  
1682 PSI (up to 5000 ft.) at 50°C

## Features:

- 240-pin 72-bit DDR3 registered Dual-In-Line Double Data Rate synchronous DRAM module for server applications
  - Module organization: dual rank 512M x 72
  - V<sub>DD</sub> = 1.5V ±0.075V, V<sub>DDQ</sub> 1.5V ±0.075V
  - 1.5V I/O ( SSTL\_15 compatible)
  - Ultra Low Profile (ULP)
  - JEDEC compatible DDR3 PLL/Register component with parity bit support for address and control bus
  - Supports ECC error detection and correction
  - On-board I2C temperature sensor with integrated serial presence-detect (SPD) EEPROM
  - Gold-contact pads
  - This module is fully pin and functional compatible to the JEDEC PC3-10600 spec. and JEDEC- Standard MO-269. (see [www.jedec.org](http://www.jedec.org))
  - The pcb and all components are manufactured according to the RoHS compliance specification [EU Directive 2002/95/EC Restriction of Hazardous Substances (RoHS)]
- 
- DDR3 - SDRAM component Micron MT41J256M8HX-15E:D**
  - 256Mx8 DDR3 SDRAM in PG-TFBGA-78 package
  - 8-bit prefetch architecture
  - Programmable CAS Latency, CAS Write Latency, Additive Latency, Burst Length and Burst Type.
  - On-Die-Termination (ODT) and Dynamic ODT for improved signal integrity.
  - Refresh. Self Refresh and Power Down Modes.
  - ZQ Calibration for output driver and ODT.
  - System Level Timing Calibration Support via Write Leveling and Multi Purpose Register (MPR) Read Pattern.

Figure: mechanical dimensions<sup>1</sup>



<sup>1</sup>the reference according MO269

This Swissbit module is an industry standard 240-pin 8-byte DDR3 registered SDRAM Dual-In-line Memory Module (RDIMM) which is organized as x72 high speed CMOS memory array. All control and address signals are re-driven on the DIMM using register devices and a PLL for the clock distribution. This reduces capacitive loading to the system bus, but adds one cycle to the SDRAM timing. De-coupling capacitors, stub resistors, calibration resistors and termination resistors are mounted on the PCB board. The module uses double data rate architecture to achieve high-speed operation. DDR3 SDRAM modules operate from a differential clock (CK and CK#). READ and WRITE accesses to a DDR3 SDRAM module is burst-oriented; accesses start at a selected location and continue for a programmed number of locations in a programmed sequence. The burst length is either four or eight locations. An auto precharge function can be enabled to provide a self-timed row precharge that is initiated at the end of a burst access. The DDR3 SDRAM devices have a multibank architecture which allows a concurrent operation that is providing a high effective bandwidth. A self refresh mode is provided and a power-saving "power-down" mode. All inputs and all full drive-strength outputs are SSTL\_15 compatible.

The DDR3 SDRAM module uses the serial presence detect (SPD) function implemented via serial EEPROM using the standard I<sup>2</sup>C protocol. This nonvolatile storage device contains 256 bytes. The first 128 bytes are utilized by the DIMM manufacturer (Swissbit) to identify the module type, the module's organization and several timing parameters. The second 128 bytes are available to the end user.

### Module Configuration

| Organization | DDR3 SDRAMs used         | Row Addr. | Device Bank Addr. | Column Addr. | Refresh | Module Bank Select |
|--------------|--------------------------|-----------|-------------------|--------------|---------|--------------------|
| 512M x 72bit | 18 x 256M x 8bit (2Gbit) | 15        | BA0, BA1, BA2     | 10           | 8k      | S0#, S1#           |

| Module Dimensions<br>in mm                            |
|-------------------------------------------------------|
| 133.35 (long) x 17.75 (high) x 4.00 [max] (thickness) |

### Timing Parameters

| Part Number          | Module Density | Transfer Rate | Clock Cycle/Data bit rate | Latency |
|----------------------|----------------|---------------|---------------------------|---------|
| SGP04G72D1BD2MT-BBRT | 4096 MB        | 8.5 GB/s      | 1.87ns / 1066MT/s         | 7-7-7   |
| SGP04G72D1BD2MT-CCRT | 4096 MB        | 10.6 GB/s     | 1.5ns / 1333MT/s          | 9-9-9   |

### Pin Name

|                         |                                                                                      |
|-------------------------|--------------------------------------------------------------------------------------|
| A0 – A9, A11, A13 – A15 | Address Inputs (A15 not functional, but included in parity check)                    |
| A10/AP                  | Address Input / Auto precharge Bit                                                   |
| A12/BC                  | Address Input / Burst chop                                                           |
| BA0 – BA2               | Bank Address Inputs                                                                  |
| DQ0 – DQ63              | Data Input / Output                                                                  |
| CB0 – CB7               | Data check bits Input / Output                                                       |
| DM0-DM8                 | Input Data Mask                                                                      |
| DQS0 – DQS8             | Data Strobe, positive line                                                           |
| DQS0# - DQS8#           | Data Strobe, negative line (only used when differential data strobe mode is enabled) |
| RAS#                    | Row Address Strobe                                                                   |
| CAS#                    | Column Address Strobe                                                                |
| WE#                     | Write Enable                                                                         |

|                    |                                                                                       |
|--------------------|---------------------------------------------------------------------------------------|
| CKE0 – CKE1        | Clock Inputs, negative line                                                           |
| S0#, S1#           | Chip Select                                                                           |
| CK0 – CK1          | Clock Inputs, positive line                                                           |
| CK0# - CK1#        | Clock Inputs, negative Line                                                           |
| Event#             | Temperature event: The EVENT# pin is asserted by the temperature sensor when critical |
| V <sub>DD</sub>    | Supply Voltage (1.5V± 0.075V)                                                         |
| V <sub>REFDQ</sub> | Reference voltage: DQ, DM (VDD/2)                                                     |
| V <sub>REFCA</sub> | Reference voltage: Control, command, and address (VDD/2)                              |
| V <sub>SS</sub>    | Ground                                                                                |
| V <sub>TT</sub>    | Termination voltage: Used for control, command, and address (VDD/2).                  |
| V <sub>DDSPD</sub> | Serial EEPROM Positive Power Supply                                                   |
| SCL                | Serial Clock for Presence Detect                                                      |
| SDA                | Serial Data Out for Presence Detect                                                   |
| SA0 – SA1          | Serial Presence Detect Address Inputs                                                 |
| ODT0, ODT1         | On-Die Termination                                                                    |
| NC                 | No Connection                                                                         |

### Pin Configuration

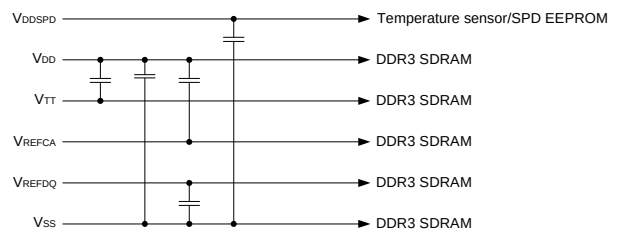
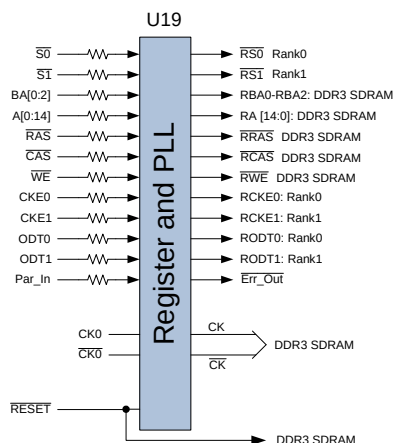
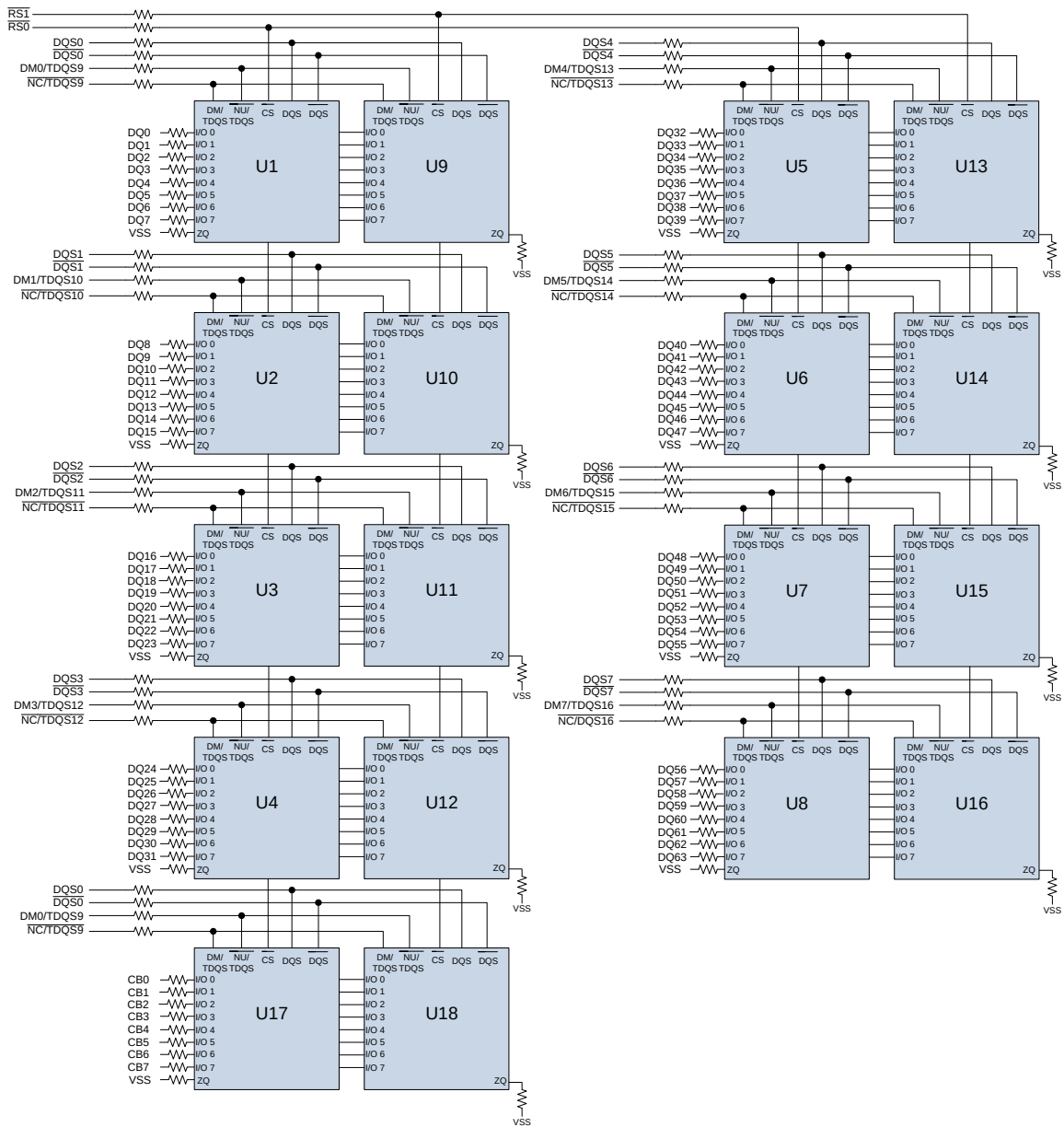
| Frontside |                    |        |                 |        |                    |         |                 |         |                 |
|-----------|--------------------|--------|-----------------|--------|--------------------|---------|-----------------|---------|-----------------|
| PIN       | Symbol             | PIN    | Symbol          | PIN    | Symbol             | PIN     | Symbol          | PIN     | Symbol          |
| Pin 1     | V <sub>REFDQ</sub> | Pin 27 | DQ18            | Pin 49 | V <sub>TT</sub>    | Pin 75  | V <sub>DD</sub> | Pin 101 | V <sub>SS</sub> |
| Pin 2     | V <sub>SS</sub>    | Pin 28 | DQ19            | Pin 50 | CKE0               | Pin 76  | S1# *           | Pin 102 | DQS6#           |
| Pin 3     | DQ0                | Pin 29 | V <sub>SS</sub> | Pin 51 | V <sub>DD</sub>    | Pin 77  | NC, ODT1 *      | Pin 103 | DQS6            |
| Pin 4     | DQ1                | Pin 30 | DQ24            | Pin 52 | BA2                | Pin 78  | V <sub>DD</sub> | Pin 104 | V <sub>SS</sub> |
| Pin 5     | V <sub>SS</sub>    | Pin 31 | DQ25            | Pin 53 | Err_Out#           | Pin 79  | NC, S2# *       | Pin 105 | DQ50            |
| Pin 6     | DQS0#              | Pin 32 | V <sub>SS</sub> | Pin 54 | V <sub>DD</sub>    | Pin 80  | V <sub>SS</sub> | Pin 106 | DQ51            |
| Pin 7     | DQS0               | Pin 33 | DQS3#           | Pin 55 | A11                | Pin 81  | DQ32            | Pin 107 | V <sub>SS</sub> |
| Pin 8     | V <sub>SS</sub>    | Pin 34 | DQS3            | Pin 56 | A7                 | Pin 82  | DQ33            | Pin 108 | DQ56            |
| Pin 9     | DQ2                | Pin 35 | V <sub>SS</sub> | Pin 57 | V <sub>DD</sub>    | Pin 83  | V <sub>SS</sub> | Pin 109 | DQ57            |
| Pin 10    | DQ3                | Pin 36 | DQ26            | Pin 58 | A5                 | Pin 84  | DQS4#           | Pin 110 | V <sub>SS</sub> |
| Pin 11    | V <sub>SS</sub>    | Pin 37 | DQ27            | Pin 59 | A4                 | Pin 85  | DQS4            | Pin 111 | DQS7#           |
| Pin 12    | DQ8                | Pin 38 | V <sub>SS</sub> | Pin 60 | V <sub>DD</sub>    | Pin 86  | V <sub>SS</sub> | Pin 112 | DQS7            |
| Pin 13    | DQ9                | Pin 39 | CB0             | Pin 61 | A2                 | Pin 87  | DQ34            | Pin 113 | V <sub>SS</sub> |
| Pin 14    | V <sub>SS</sub>    | Pin 40 | CB1             | Pin 62 | V <sub>DD</sub>    | Pin 88  | DQ35            | Pin 114 | DQ58            |
| Pin 15    | DQS1#              | Pin 41 | V <sub>SS</sub> | Pin 63 | RFU                | Pin 89  | V <sub>SS</sub> | Pin 115 | DQ59            |
| Pin 16    | DQS1               | Pin 42 | DQS8#           | Pin 64 | RFU                | Pin 90  | DQ40            | Pin 116 | V <sub>SS</sub> |
| Pin 17    | V <sub>SS</sub>    | Pin 43 | DQS8            | Pin 65 | V <sub>DD</sub>    | Pin 91  | DQ41            | Pin 117 | SA0             |
| Pin 18    | DQ10               | Pin 44 | V <sub>SS</sub> | Pin 66 | V <sub>DD</sub>    | Pin 92  | V <sub>SS</sub> | Pin 118 | SCL             |
| Pin 19    | DQ11               | Pin 45 | CB2             | Pin 67 | V <sub>REFCA</sub> | Pin 93  | DQS5#           | Pin 119 | SA2             |
| Pin 20    | V <sub>SS</sub>    | Pin 46 | CB3             | Pin 68 | Par_In             | Pin 94  | DQS5            | Pin 120 | V <sub>TT</sub> |
| Pin 21    | DQ16               | Pin 47 | V <sub>SS</sub> | Pin 69 | V <sub>DD</sub>    | Pin 95  | V <sub>SS</sub> |         |                 |
| Pin 22    | DQ17               | Pin 48 | V <sub>TT</sub> | Pin 70 | A10/ AP            | Pin 96  | DQ42            |         |                 |
| Pin 23    | V <sub>SS</sub>    |        |                 | Pin 71 | BA0                | Pin 97  | DQ43            |         |                 |
| Pin 24    | DQS2#              |        |                 | Pin 72 | V <sub>DD</sub>    | Pin 98  | V <sub>SS</sub> |         |                 |
| Pin 25    | DQS2               |        |                 | Pin 73 | WE#                | Pin 99  | DQ48            |         |                 |
| Pin 26    | V <sub>SS</sub>    |        |                 | Pin 74 | CAS#               | Pin 100 | DQ49            |         |                 |

| Backside |                 |         |                 |         |                 |         |                 |         |                           |
|----------|-----------------|---------|-----------------|---------|-----------------|---------|-----------------|---------|---------------------------|
| Pin      | Symbol          | Pin     | Symbol          | Pin     | Symbol          | Pin     | Symbol          | Pin     | Symbol                    |
| Pin 121  | V <sub>SS</sub> | Pin 147 | DQ23            | Pin 169 | NC, CKE1 *      | Pin 195 | ODT0            | Pin 221 | (T)DQS15 *                |
| Pin 122  | DQ4             | Pin 148 | V <sub>SS</sub> | Pin 170 | V <sub>DD</sub> | Pin 196 | A13, NC *       | Pin 222 | (T)DQS15# *               |
| Pin 123  | DQ5             | Pin 149 | DQ28            | Pin 171 | NC, A15 *       | Pin 197 | V <sub>DD</sub> | Pin 223 | V <sub>SS</sub>           |
| Pin 124  | V <sub>SS</sub> | Pin 150 | DQ29            | Pin 172 | A14, NC *       | Pin 198 | NC, S3# *       | Pin 224 | DQ54                      |
| Pin 125  | (T)DQS9# *      | Pin 151 | V <sub>SS</sub> | Pin 173 | V <sub>DD</sub> | Pin 199 | V <sub>SS</sub> | Pin 225 | DQ55                      |
| Pin 126  | (T)DQS9# *      | Pin 152 | (T)DQS12 *      | Pin 174 | A12, BC         | Pin 200 | DQ36            | Pin 226 | V <sub>SS</sub>           |
| Pin 127  | V <sub>SS</sub> | Pin 153 | (T)DQS12# *     | Pin 175 | A9              | Pin 201 | DQ37            | Pin 227 | DQ60                      |
| Pin 128  | DQ6             | Pin 154 | V <sub>SS</sub> | Pin 176 | V <sub>DD</sub> | Pin 202 | V <sub>SS</sub> | Pin 228 | DQ61                      |
| Pin 129  | DQ7             | Pin 155 | DQ30            | Pin 177 | A8              | Pin 203 | (T)DQS13 *      | Pin 229 | V <sub>SS</sub>           |
| Pin 130  | V <sub>SS</sub> | Pin 156 | DQ31            | Pin 178 | A6              | Pin 204 | (T)DQS13# *     | Pin 230 | (T)DQS16 *                |
| Pin 131  | DQ12            | Pin 157 | V <sub>SS</sub> | Pin 179 | V <sub>DD</sub> | Pin 205 | V <sub>SS</sub> | Pin 231 | (T)DQS16# *               |
| Pin 132  | DQ13            | Pin 158 | CB4             | Pin 180 | A3              | Pin 206 | DQ38            | Pin 232 | V <sub>SS</sub>           |
| Pin 133  | V <sub>SS</sub> | Pin 159 | CB5             | Pin 181 | A1              | Pin 207 | DQ39            | Pin 233 | DQ62                      |
| Pin 134  | (T)DQS10 *      | Pin 160 | V <sub>SS</sub> | Pin 182 | V <sub>DD</sub> | Pin 208 | V <sub>SS</sub> | Pin 234 | DQ63                      |
| Pin 135  | (T)DQS10# *     | Pin 161 | (T)DQS17 *      | Pin 183 | V <sub>DD</sub> | Pin 209 | DQ44            | Pin 235 | V <sub>SS</sub>           |
| Pin 136  | V <sub>SS</sub> | Pin 162 | (T)DQS17# *     | Pin 184 | CK0             | Pin 210 | DQ45            | Pin 236 | VDD <sub>SPD</sub>        |
| Pin 137  | DQ14            | Pin 163 | V <sub>SS</sub> | Pin 185 | CK0#            | Pin 211 | V <sub>SS</sub> | Pin 237 | SA1                       |
| Pin 138  | DQ15            | Pin 164 | CB6             | Pin 186 | V <sub>DD</sub> | Pin 212 | (T)DQS14 *      | Pin 238 | SDA                       |
| Pin 139  | V <sub>SS</sub> | Pin 165 | CB7             | Pin 187 | NC              | Pin 213 | (T)DQS14# *     | Pin 239 | V <sub>SS</sub> /Event# * |
| Pin 140  | DQ20            | Pin 166 | V <sub>SS</sub> | Pin 188 | A0              | Pin 214 | V <sub>SS</sub> | Pin 240 | V <sub>TT</sub>           |
| Pin 141  | DQ21            | Pin 167 | NC(TEST) *      | Pin 189 | V <sub>DD</sub> | Pin 215 | DQ46            |         |                           |
| Pin 142  | V <sub>SS</sub> | Pin 168 | RESET#          | Pin 190 | BA1             | Pin 216 | DQ47            |         |                           |
| Pin 143  | (T)DQS11 *      |         |                 | Pin 191 | V <sub>DD</sub> | Pin 217 | V <sub>SS</sub> |         |                           |
| Pin 144  | (T)DQS11# *     |         |                 | Pin 192 | RAS#            | Pin 218 | DQ52            |         |                           |
| Pin 145  | V <sub>SS</sub> |         |                 | Pin 193 | S0#             | Pin 219 | DQ53            |         |                           |
| Pin 146  | DQ22            |         |                 | Pin 194 | V <sub>DD</sub> | Pin 220 | V <sub>SS</sub> |         |                           |

\*) Following pin functions are depending on module configuration:

- (T)DQS is DQS for x4 based modules and TDQS for x8 based modules
- S1# is connected, but not used functionally for single rank DIMMs
- ODT1, CKE1 are not used for single rank modules
- S2# and S3# are only used for quad rank modules
- Event# is only used with temperature sensor equipped modules
- A13, A14, A15 are included in parity calculation. Function depends on DRAM address configuration
- A13 used for 1Gb, A13 & A14 for 2Gb, A13-A15 for 4Gb SDRAM

**FUNCTIONAL BLOCK DIAGRAM 4096MB DDR3 SDRAM RDIMM,  
2 RANKS AND 18 COMPONENTS**



## MAXIMUM ELECTRICAL DC CHARACTERISTICS

| PARAMETER/ CONDITION                                                                                                                                       | SYMBOL            | MIN  | MAX   | UNITS   |
|------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------|------|-------|---------|
| Supply Voltage                                                                                                                                             | $V_{DD}$          | -0.4 | 1.975 | V       |
| I/O Supply Voltage                                                                                                                                         | $V_{DDQ}$         | -0.4 | 1.975 | V       |
| $V_{DDL}$ Supply Voltage                                                                                                                                   | $V_{DDL}$         | -0.4 | 1.975 | V       |
| Voltage on any pin relative to $V_{SS}$                                                                                                                    | $V_{in}, V_{out}$ | -0.4 | 1.975 | V       |
| <b>INPUT LEAKAGE CURRENT</b><br>Any input $0V \leq V_{IN} \leq V_{DD}$ , $V_{REF}$ pin $0V \leq V_{IN} \leq 0.95V$<br>(All other pins not under test = 0V) | $I_I$             |      |       | $\mu A$ |
|                                                                                                                                                            |                   | -16  | 16    |         |
|                                                                                                                                                            |                   | -16  | 16    |         |
|                                                                                                                                                            |                   | -2   | 2     |         |
| <b>OUTPUT LEAKAGE CURRENT</b><br>(DQ's and ODT are disabled; $0V \leq V_{OUT} \leq V_{DDQ}$ )                                                              | $I_{OZ}$          | -5   | 5     | $\mu A$ |
|                                                                                                                                                            |                   |      |       |         |
| $V_{REF}$ LEAKAGE CURRENT ; $V_{REF}$ is on a valid level                                                                                                  | $I_{VREF}$        | -8   | 8     | $\mu A$ |

## DC OPERATING CONDITIONS

| PARAMETER/ CONDITION             | SYMBOL       | MIN                          | NOM                   | MAX                          | UNITS |
|----------------------------------|--------------|------------------------------|-----------------------|------------------------------|-------|
| Supply Voltage                   | $V_{DD}$     | 1.425                        | 1.5                   | 1.575                        | V     |
| I/O Supply Voltage               | $V_{DDQ}$    | 1.425                        | 1.5                   | 1.575                        | V     |
| $V_{DDL}$ Supply Voltage         | $V_{DDL}$    | 1.425                        | 1.5                   | 1.575                        | V     |
| I/O Reference Voltage            | $V_{REF}$    | $0.49 \times V_{DDQ}$        | $0.50 \times V_{DDQ}$ | $0.51 \times V_{DDQ}$        | V     |
| I/O Termination Voltage (system) | $V_{TT}$     | $0.49 \times V_{DDQ} - 20mV$ | $0.50 \times V_{DDQ}$ | $0.51 \times V_{DDQ} + 20mV$ | V     |
| Input High (Logic 1) Voltage     | $V_{IH(DC)}$ | $V_{REF} + 0.1$              |                       | $V_{DDQ} + 0.3$              | V     |
| Input Low (Logic 0) Voltage      | $V_{IL(DC)}$ | -0.3                         |                       | $V_{REF} - 0.1$              | V     |

## AC INPUT OPERATING CONDITIONS

| PARAMETER/ CONDITION         | SYMBOL       | MIN               | MAX               | UNITS |
|------------------------------|--------------|-------------------|-------------------|-------|
| Input High (Logic 1) Voltage | $V_{IH(AC)}$ | $V_{REF} + 0.175$ | -                 | V     |
| Input Low (Logic 0) Voltage  | $V_{IL(AC)}$ | -                 | $V_{REF} - 0.175$ | V     |

## CAPACITANCE

At DDR3 data rates, it is recommended to simulate the performance of the module to achieve optimum values. When inductance and delay parameters associated with trace lengths are used in simulations, they are significantly more accurate and realistic than a gross estimation of module capacitance. Simulations can then render a considerably more accurate result. JEDEC modules are now designed by using simulations to close timing budgets.

# I<sub>DD</sub> Specifications and Conditions

(0°C ≤ T<sub>CASE</sub> ≤ + 85°C; V<sub>DDQ</sub> = +1.5V ± 0.075V, V<sub>DD</sub> = +1.5V ± 0.075V)

| Parameter<br>& Test Condition                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                      | Symbol            | max.              |          | Unit |    |
|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------|-------------------|----------|------|----|
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                    |                   | 10600-999         | 8500-777 |      |    |
| <b>OPERATING CURRENT *) :</b><br>One device bank Active-Precharge;<br>t <sub>RC</sub> = t <sub>RC</sub> (I <sub>DD</sub> ); t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ); CKE is HIGH, CS# is HIGH between valid commands;<br>DQ inputs changing once per clock cycle; Address and control inputs changing once every two clock cycles                                                                                                                                                                                     | I <sub>DD0</sub>  | 873               | 783      | mA   |    |
| <b>OPERATING CURRENT *) :</b><br>One device bank; Active-Read-Precharge;<br>I <sub>OUT</sub> = 0mA; BL = 4, CL = CL (I <sub>DD</sub> ), AL = 0;<br>t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ), t <sub>RC</sub> = t <sub>RC</sub> (I <sub>DD</sub> ), t <sub>RAS</sub> = t <sub>RAS</sub> MIN (I <sub>DD</sub> ), t <sub>RCD</sub> = t <sub>RCD</sub> (I <sub>DD</sub> ); CKE is HIGH, CS# is HIGH between valid commands; Address inputs changing once every two clock cycles; Data Pattern is same as I <sub>DD4W</sub> | I <sub>DD1</sub>  | 1008              | 963      | mA   |    |
| <b>PRECHARGE POWER-DOWN CURRENT:</b><br>All device banks idle; Power-down mode;<br>t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ); CKE is LOW; All Control and Address bus inputs are not changing; DQ's are floating at V <sub>REF</sub>                                                                                                                                                                                                                                                                                    | Fast Exit         | I <sub>DD2P</sub> | 540      | 450  | mA |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                    | Slow Exit         |                   | 216      | 216  |    |
| <b>PRECHARGE QUIET STANDBY CURRENT:</b><br>All device banks idle;<br>t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ); CKE is HIGH, CS# is HIGH;<br>All Control and Address bus inputs are not changing;<br>DQ's are floating at V <sub>REF</sub>                                                                                                                                                                                                                                                                              | I <sub>DD2Q</sub> | 630               | 540      | mA   |    |
| <b>PRECHARGE STANDBY CURRENT:</b><br>All device banks idle;<br>t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ); CKE is HIGH, CS# is HIGH;<br>All other Control and Address bus inputs are changing once every two clock cycles; DQ inputs changing once per clock cycle                                                                                                                                                                                                                                                       | I <sub>DD2N</sub> | 666               | 576      | mA   |    |
| <b>ACTIVE POWER-DOWN CURRENT:</b><br>All device banks open; t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ); CKE is LOW; All Control and Address bus inputs are not changing; DQ's are floating at V <sub>REF</sub> (always fast exit)                                                                                                                                                                                                                                                                                        | I <sub>DD3P</sub> | 630               | 540      | mA   |    |
| <b>ACTIVE STANDBY CURRENT:</b><br>All device banks open; t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ), t <sub>RAS</sub> = t <sub>RAS</sub> MAX (I <sub>DD</sub> ), t <sub>RP</sub> = t <sub>RP</sub> (I <sub>DD</sub> ); CKE is HIGH, CS# is HIGH between valid commands; All other Control and Address bus inputs are changing once every two clock cycles; DQ inputs changing once per clock cycle                                                                                                                       | I <sub>DD3N</sub> | 720               | 630      | mA   |    |
| <b>OPERATING READ CURRENT:</b><br>All device banks open, Continuous burst reads; One module rank active; I <sub>OUT</sub> = 0mA; BL = 4, CL = CL (I <sub>DD</sub> ), AL = 0; t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ), t <sub>RAS</sub> = t <sub>RAS</sub> MAX (I <sub>DD</sub> ), t <sub>RP</sub> = t <sub>RP</sub> (I <sub>DD</sub> ); CKE is HIGH, CS# is HIGH between valid commands; Address bus inputs are changing once every two clock cycles; DQ inputs changing once per clock cycle                         | I <sub>DD4R</sub> | 1548              | 1368     | mA   |    |

| Parameter<br>& Test Condition                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                 | Symbol            | max.      |          | Unit |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------|-----------|----------|------|
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |                   | 10600-999 | 8500-777 |      |
| <b>OPERATING WRITE CURRENT:</b><br>All device banks open, Continuous burst writes; One module rank active; BL = 4, CL = CL (I <sub>DD</sub> ), AL = 0;<br>t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ), t <sub>RAS</sub> = t <sub>RAS</sub> MAX (I <sub>DD</sub> ), t <sub>RP</sub> = t <sub>RP</sub> (I <sub>DD</sub> );<br>CKE is HIGH, CS# is HIGH between valid commands;<br>Address bus inputs are changing once every two clock cycles; DQ inputs changing once per clock cycle                                                                                                 | I <sub>DD4W</sub> | 1593      | 1413     | mA   |
| <b>BURST REFRESH CURRENT:</b><br>t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ); refresh command at every t <sub>RFC</sub> (I <sub>DD</sub> ) interval, CKE is HIGH, CS# is HIGH between valid commands; All other Control and Address bus inputs are changing once every two clock cycles; DQ inputs changing once per clock cycle                                                                                                                                                                                                                                                     | I <sub>DD5</sub>  | 3600      | 3420     | mA   |
| <b>SELF REFRESH CURRENT:</b><br>CK and CK# at 0V; CKE ≤ 0.2V; All other Control and Address bus inputs are floating at V <sub>REF</sub> ; DQ's are floating at V <sub>REF</sub>                                                                                                                                                                                                                                                                                                                                                                                                               | I <sub>DD6</sub>  | 216       | 216      | mA   |
| <b>OPERATING CURRENT*) :</b><br>Four device bank interleaving READs, I <sub>OUT</sub> = 0mA; BL = 4, CL = CL (I <sub>DD</sub> ), AL = t <sub>RCD</sub> (I <sub>DD</sub> ) - 1 x t <sub>CK</sub> (I <sub>DD</sub> ); t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ), t <sub>RC</sub> = t <sub>RC</sub> (I <sub>DD</sub> ), t <sub>RRD</sub> = t <sub>RRD</sub> (I <sub>DD</sub> ), t <sub>RCD</sub> = t <sub>RCD</sub> (I <sub>DD</sub> ); CKE is HIGH, CS# is HIGH between valid commands; Address bus inputs are not changing during DESELECT; DQ inputs changing once per clock cycle | I <sub>DD7</sub>  | 3573      | 3123     | mA   |

\*) Value calculated as one module rank in this operating condition, and all other module ranks in IDD2P (CKE LOW) mode.

#### TIMING VALUES USED FOR I<sub>DD</sub> MEASUREMENT

| I <sub>DD</sub> MEASUREMENT CONDITIONS  |           |          |                 |
|-----------------------------------------|-----------|----------|-----------------|
| SYMBOL                                  | 10600-999 | 8500-777 | Unit            |
| CL (I <sub>DD</sub> )                   | 9         | 7        | t <sub>CK</sub> |
| t <sub>RCD</sub> (I <sub>DD</sub> )     | 13.5      | 13.125   | ns              |
| t <sub>RC</sub> (I <sub>DD</sub> )      | 49.5      | 50.625   | ns              |
| t <sub>RRD</sub> (I <sub>DD</sub> )     | 6         | 7.5      | ns              |
| t <sub>CK</sub> (I <sub>DD</sub> )      | 1.5       | 1.87     | ns              |
| t <sub>RAS</sub> MIN (I <sub>DD</sub> ) | 36        | 37.5     | ns              |
| t <sub>RAS</sub> MAX (I <sub>DD</sub> ) | 70,200    | 70,200   | ns              |
| t <sub>RP</sub> (I <sub>DD</sub> )      | 13.5      | 13.125   | ns              |
| t <sub>RFC</sub> (I <sub>DD</sub> )     | 160       | 160      | ns              |



# DDR3 SDRAM COMPONENT ELECTRICAL CHARACTERISTICS AND RECOMMENDED AC OPERATING CONDITIONS

(0°C ≤ T<sub>CASE</sub> ≤ + 85°C; V<sub>DDQ</sub> = +1.5V ± 0.075V, V<sub>DD</sub> = +1.5V ± 0.075V)

| AC CHARACTERISTICS                                                 |         |                               | 10600-999 |        | 8500-777 |        | Unit                     |
|--------------------------------------------------------------------|---------|-------------------------------|-----------|--------|----------|--------|--------------------------|
| PARAMETER                                                          |         | SYMBOL                        | MIN       | MAX    | Min      | MAX    |                          |
| Clock cycle time                                                   | CL = 10 | t <sub>CK</sub> (10)          | 1.5       | <1.875 | -        | -      | ns                       |
|                                                                    | CL = 9  | t <sub>CK</sub> (9)           | 1.5       | <1.875 | -        | -      | ns                       |
|                                                                    | CL = 8  | t <sub>CK</sub> (8)           | 1.875     | <2.5   | -        | -      | ns                       |
|                                                                    | CL = 7  | t <sub>CK</sub> (7)           | 1.875     | <2.5   | 1.875    | <2.5   | ns                       |
|                                                                    | CL = 6  | t <sub>CK</sub> (6)           | 2.5       | 3.3    | 2.5      | 3.3    | ns                       |
| CK high-level width                                                |         | t <sub>CH</sub> (avg)         | 0.47      | 0.53   | 0.47     | 0.53   | t <sub>CK</sub>          |
| CK low-level width                                                 |         | t <sub>CL</sub> (avg)         | 0.47      | 0.53   | 0.47     | 0.53   | t <sub>CK</sub>          |
| Data-out high-impedance window from CK/CK#                         |         | t <sub>HZ</sub>               |           | 250    |          | 300    | ps                       |
| Data-out low-impedance window from CK/CK#                          |         | t <sub>LZ</sub>               | -500      | 250    | -600     | 300    | ps                       |
| DQ and DM input setup time relative to DQS                         |         | t <sub>DS(Base)</sub>         | 30        |        | 25       |        | ps                       |
| DQ and DM input hold time relative to DQS                          |         | t <sub>DH(Base)</sub>         | 65        |        | 100      |        | ps                       |
| DQ and DM input setup time relative to DQS V <sub>REF</sub> =1V/ns |         | t <sub>DS1V</sub>             | 180       |        | 200      |        | ps                       |
| DQ and DM input hold time relative to DQS V <sub>REF</sub> =1V/ns  |         | t <sub>DH1V</sub>             | 165       |        | 200      |        | ps                       |
| DQ and DM input pulse width ( for each input )                     |         | t <sub>DIPW</sub>             | 400       |        | 490      |        | ps                       |
| DQS, DQS# to DQ skew, per access                                   |         | t <sub>DQSQ</sub>             |           | 125    |          | 150    | ps                       |
| DQ-DQS hold, DQS to first DQ to go non-valid, per access           |         | t <sub>QH</sub>               | 0.38      |        | 0.38     |        | t <sub>CK</sub><br>(AVG) |
| DQS input high pulse width                                         |         | t <sub>DQSH</sub>             | 0.45      | 0.55   | 0.45     | 0.55   | t <sub>CK</sub>          |
| DQS input low pulse width                                          |         | t <sub>DQSL</sub>             | 0.45      | 0.55   | 0.45     | 0.55   | t <sub>CK</sub>          |
| DQS, DQS# rising to/from CK, CK#                                   |         | t <sub>DQSCK</sub>            | -255      | 255    | -300     | 300    | ps                       |
| DQS, DQS# rising to/from CK, CK# when DLL disabled                 |         | t <sub>DQSCK</sub><br>DLL DIS | 1         | 10     | 1        | 10     | ns                       |
| DQS falling edge to CK rising - setup time                         |         | t <sub>DSS</sub>              | 0.2       |        | 0.2      |        | t <sub>CK</sub>          |
| DQS falling edge from CK rising - hold time                        |         | t <sub>DSH</sub>              | 0.2       |        | 0.2      |        | t <sub>CK</sub>          |
| DQS read preamble                                                  |         | t <sub>RPRE</sub>             | 0.9       | Note1  | 0.9      | Note1  | t <sub>CK</sub>          |
| DQS read postamble                                                 |         | t <sub>RPST</sub>             | 0.3       | Note2  | 0.3      | Note2  | t <sub>CK</sub>          |
| DQS write preamble                                                 |         | t <sub>WPRE</sub>             | 0.9       |        | 0.9      |        | t <sub>CK</sub>          |
| DQS write postamble                                                |         | t <sub>WPST</sub>             | 0.3       |        | 0.3      |        | t <sub>CK</sub>          |
| Positive DQS latching edge to associated clock edge                |         | t <sub>DQSS</sub>             | - 0.25    | + 0.25 | - 0.25   | + 0.25 | t <sub>CK</sub>          |
| Address and control input pulse width ( for each input )           |         | t <sub>IPW</sub>              | 620       |        | 780      |        | ps                       |
| CTRL, CMD, Addr setup to CK, CK#                                   |         | t <sub>IS(Base)</sub>         | 65        |        | 125      |        | ps                       |
| CTRL, CMD, Addr setup to CK, CK# V <sub>REF</sub> @ 1V/ns          |         | t <sub>IS(1V)</sub>           | 240       |        | 300      |        | ps                       |

- 1 The maximum preamble is bound by t<sub>LZDQS</sub> (MAX)
- 2 The maximum postamble is bound by t<sub>HZDQS</sub> (MAX)

# DDR3 SDRAM COMPONENT ELECTRICAL CHARACTERISTICS AND RECOMMENDED AC OPERATING CONDITIONS (Continued)

(0°C ≤ T<sub>CASE</sub> ≤ + 85°C; V<sub>DDQ</sub> = +1.5V ± 0.075V, V<sub>DD</sub> = +1.5V ± 0.075V)

| AC CHARACTERISTICS                                                              |                       | 10600-999                                          |        | 8500-777                                           |        | Unit            |
|---------------------------------------------------------------------------------|-----------------------|----------------------------------------------------|--------|----------------------------------------------------|--------|-----------------|
| PARAMETER                                                                       | SYMBOL                | MIN                                                | MAX    | MIN                                                | MAX    |                 |
| CTRL, CMD, Addr hold to CK,CK#                                                  | t <sub>IH(Base)</sub> | 140                                                |        | 200                                                |        | ps              |
| CTRL, CMD, Addr hold to CK,CK# V <sub>REF</sub> @ 1V/ns                         | t <sub>IH(1V)</sub>   | 240                                                |        | 300                                                |        | ps              |
| CAS# to CAS# command delay                                                      | t <sub>CCD</sub>      | 4                                                  |        | 4                                                  |        | t <sub>CK</sub> |
| ACT to ACT (same bank) command period                                           | t <sub>RC</sub>       | 49.5                                               |        | 50.625                                             |        | ns              |
| ACT bank a to ACT bank b command                                                | t <sub>RRD</sub>      | max<br>4nCK,10ns                                   |        | max<br>4nCK,7.5ns                                  |        | ns              |
| ACT to READ or WRITE delay                                                      | t <sub>RCD</sub>      | 13.5                                               |        | 13.125                                             |        | ns              |
| Four bank Activate period                                                       | t <sub>FAW</sub>      | 30                                                 |        | 37.5                                               |        | ns              |
| 1K Page size                                                                    |                       | 45                                                 |        | 50                                                 |        |                 |
| 2K Page size                                                                    |                       |                                                    |        |                                                    |        |                 |
| ACT to PRE command                                                              | t <sub>RAS</sub>      | 36                                                 | 70,200 | 37.5                                               | 70,200 | ns              |
| Internal READ to PRE command delay                                              | t <sub>RTP</sub>      | max<br>4nCK,7.5ns                                  |        | max<br>4nCK,7.5ns                                  |        | ns              |
| Write recovery time                                                             | t <sub>WR</sub>       | 15                                                 |        | 15                                                 |        | ns              |
| Auto precharge write recovery + precharge time                                  | t <sub>DAL</sub>      | t <sub>WR</sub> + t <sub>RP</sub> /t <sub>CK</sub> |        | t <sub>WR</sub> + t <sub>RP</sub> /t <sub>CK</sub> |        | ns              |
| Internal WRITE to READ command delay                                            | t <sub>WTR</sub>      | max<br>4nCK,7.5ns                                  |        | max<br>4nCK,7.5ns                                  |        | ns              |
| PRE command period                                                              | t <sub>RP</sub>       | 15                                                 |        | 13.125                                             |        | ns              |
| LOAD MODE command cycle time                                                    | t <sub>MRD</sub>      | 4                                                  |        | 4                                                  |        | t <sub>CK</sub> |
| REF to ACT or REF to REF command interval                                       | t <sub>RFC</sub>      | 160                                                | 70,200 | 160                                                | 70,200 | ns              |
| Average periodic refresh interval (0°C ≤ T <sub>CASE</sub> ≤ 85 °C)             | t <sub>REFI</sub>     |                                                    | 7.8    |                                                    | 7.8    | μs              |
| (85°C ≤ T <sub>CASE</sub> ≤ 95 °C)                                              | t <sub>REFI</sub>     |                                                    | 3.9    |                                                    | 3.9    | μs              |
| RTT turn-on from ODTL on reference                                              | t <sub>AON</sub>      | -250                                               | 250    | -300                                               | 300    | ps              |
| RTT turn-on from ODTL off reference                                             | t <sub>AOFF</sub>     | 0.3                                                | 0.7    | 0.3                                                | 0.7    | t <sub>CK</sub> |
| Asynchronous RTT turn-on delay (power Down with DLL off)                        | t <sub>AONPD</sub>    | 2                                                  | 8,5    | 2                                                  | 8,5    | ns              |
| Asynchronous RTT turn-off delay (power Down with DLL off)                       | t <sub>AOFPD</sub>    | 2                                                  | 8,5    | 2                                                  | 8,5    | ns              |
| RTT dynamic change skew                                                         | t <sub>ADC</sub>      | 0.3                                                | 0.7    | 0.3                                                | 0.7    | t <sub>CK</sub> |
| Exit self refresh to commands not requiring a locked DLL                        | t <sub>XS</sub>       | max<br>5nCK,tR<br>FC + 10ns                        |        | max<br>5nCK,tR<br>FC + 10ns                        |        | ns              |
| Write levelling setup from rising CK, CK# crossing to rising DQS, DQS# crossing | t <sub>WLS</sub>      | 195                                                |        | 245                                                |        | ps              |
| Write levelling setup from rising DQS, DQS# crossing to rising CK, CK# crossing | t <sub>WLH</sub>      | 195                                                |        | 245                                                |        | ps              |
| First DQS, DQS# rising edge                                                     | t <sub>WLMRD</sub>    | 40                                                 |        | 40                                                 |        | t <sub>CK</sub> |
| DQS, DQS# delay                                                                 | t <sub>WLDQSEN</sub>  | 25                                                 |        | 25                                                 |        | t <sub>CK</sub> |
| Exit reset from CKE HIGH to a valid command                                     | t <sub>XPR</sub>      | max<br>5nCK,<br>tRFC +<br>10ns                     |        | max<br>5nCK,<br>tRFC +<br>10ns                     |        |                 |
| Begin power supply ramp to power supplies stable                                | t <sub>VDDPR</sub>    |                                                    | 200    |                                                    | 200    | ms              |

## DDR3 SDRAM COMPONENT ELECTRICAL CHARACTERISTICS AND RECOMMENDED AC OPERATING CONDITIONS (Continued)

(0°C ≤ T<sub>CASE</sub> ≤ + 85°C; V<sub>DDQ</sub> = +1.5V ± 0.075V, V<sub>DD</sub> = +1.5V ± 0.075V)

| AC CHARACTERISTICS                                |                  | 10600-999               |     | 8500-777                |     | Unit |
|---------------------------------------------------|------------------|-------------------------|-----|-------------------------|-----|------|
| PARAMETER                                         | SYMBOL           | MIN                     | MAX | Min                     | MAX |      |
| RESET# LOW to power supplies stable               | t <sub>RPS</sub> |                         | 200 |                         | 200 | ms   |
| RESET# LOW to I/O and RTT High-Z                  | t <sub>IOZ</sub> |                         | 20  |                         | 20  | ns   |
| Exit precharge power-down to any non-READ command | t <sub>XP</sub>  | max<br>3nCK, 6ns        |     | max<br>3nCK, 7.5ns      |     |      |
| CKE minimum high/low time                         | t <sub>CKE</sub> | max<br>3nCK,<br>5.625ns |     | max<br>3nCK,<br>5.625ns |     |      |

## Register Specifications

| Parameter                                    | Symbol                | Pins                      | Min                           | Max                           | Units |
|----------------------------------------------|-----------------------|---------------------------|-------------------------------|-------------------------------|-------|
| DV supply voltage                            | V <sub>DD</sub>       | -                         | 1.425                         | 1.575                         | V     |
| DC reference voltage                         | V <sub>REF</sub>      | -                         | 0.49 × V <sub>DD</sub> - 20mV | 0.51 × V <sub>DD</sub> + 20mV | V     |
| DC termination Voltage                       | V <sub>TT</sub>       | -                         | 0.49 × V <sub>DD</sub> - 20mV | 0.51 × V <sub>DD</sub> + 20mV | V     |
| DC high-level input voltage                  | V <sub>IH(DC)</sub>   | Address, control, command | V <sub>REF</sub> + 100        | V <sub>DD</sub> + 400         | mV    |
| DC low-level input voltage                   | V <sub>IL(DC)</sub>   | Address, control, command | -400                          | V <sub>REF</sub> - 100        | mV    |
| AC high-level input voltage                  | V <sub>IH(AC)</sub>   | Address, control, command | V <sub>REF</sub> + 175        | V <sub>DD</sub> + 400         | mV    |
| AC low-level input voltage                   | V <sub>IL(AC)</sub>   | Address, control, command | -400                          | V <sub>REF</sub> - 175        | mV    |
| High-level output current                    | I <sub>OH</sub>       | Err_Out#                  | -                             | TBD                           | mA    |
| Low-level output current                     | I <sub>OL</sub>       | Err_Out#                  | TBD                           | TBD                           | mA    |
| High-level input voltage                     | V <sub>IH(CMOS)</sub> | RESET#, MIRROR            | 0.65 × V <sub>DD</sub>        | V <sub>DD</sub>               | V     |
| Low-level input voltage                      | V <sub>IL(CMOS)</sub> | RESET#, MIRROR            | 0                             | .35 × V <sub>DD</sub>         | V     |
| Differential input cross point voltage range | V <sub>IX(AC)</sub>   | CK, CK#, FBIN, FBIN#      | 0.5 × V <sub>DD</sub> - 175mV | 0.5 × V <sub>DD</sub> + 175mV | V     |
| Differential input voltage                   | V <sub>ID(AC)</sub>   | CK, CK#                   | 350                           | TBD                           | mV    |

Notes: 1. Timing and switching specifications for the register listed above are critical for proper operation of the DDR3 SDRAM RDIMMs. These are meant to be a subset of the parameters for the specific device used on the module.

## Temperature Sensor with Serial Presence-Detect EEPROM



## Temperature Sensor with Serial Presence-Detect EEPROM Operating Conditions

| Parameter / Condition                        | Symbol             | Min   | Max                    | Unit |
|----------------------------------------------|--------------------|-------|------------------------|------|
| Supply voltage                               | V <sub>DDSPD</sub> | +3    | +3.6                   | V    |
| Supply current: V <sub>dd</sub> = 3.3V       | I <sub>DD</sub>    |       | +2.0                   | mA   |
| Input high voltage: Logic 1; SCL, SDA        | V <sub>IH</sub>    | +1.45 | V <sub>DDSPD</sub> + 1 | V    |
| Input low voltage: Logic 0; SCL, SDA         | V <sub>IL</sub>    | -     | 550                    | mV   |
| Output low voltage: I <sub>out</sub> = 2.1mA | V <sub>OL</sub>    | -     | 400                    | mV   |
| Input current                                | I <sub>in</sub>    | -5.0  | 5.0                    | μA   |
| Temperature sensing range                    |                    | TBD   | TBD                    | °C   |
| Temperature sensor accuracy                  |                    | TBD   | TBD                    | °C   |

### A.C. Characteristics of Temperature Sensor

V<sub>CC</sub> = 3.3 V ± 10%, T<sub>A</sub> = -40°C to +125°C

| Symbol               | Parameter / Condition                         | Min  | Max | Unit |
|----------------------|-----------------------------------------------|------|-----|------|
| f <sub>SCL</sub>     | SCL clock frequency                           | 10   | 400 | kHz  |
| t <sub>BUF</sub>     | Bus Free Time Between STOP and START          | 1300 |     | ns   |
| t <sub>F</sub>       | SDA fall time                                 |      | 300 | ns   |
| t <sub>R</sub>       | SDA rise time                                 |      | 300 | ns   |
| t <sub>HD:DAT</sub>  | Data hold time (accepted for Input Data)      | 0    |     | ns   |
|                      | Data Hold Time (guaranteed for Output Data)   | 300  | 900 | ns   |
| t <sub>H:STA</sub>   | Start condition hold time                     | 600  |     | ns   |
| t <sub>HIGH</sub>    | High Period of SCL                            | 600  |     | ns   |
| t <sub>LOW</sub>     | Low Period of SCL                             | 1300 |     | ns   |
| t <sub>SU:DAT</sub>  | Data setup time                               | 100  |     | ns   |
| t <sub>SU:STA</sub>  | Start condition setup time                    | 600  |     | ns   |
| t <sub>SU:STO</sub>  | Stop condition setup time                     | 600  |     | ns   |
| t <sub>TIMEOUT</sub> | SMBus SCL Clock Low Timeout                   | 25   | 35  | ms   |
| t <sub>i</sub>       | Noise Pulse Filtered at SCL and SDA Inputs    |      | 100 | ns   |
| t <sub>WR</sub>      | Write Cycle Time                              |      | 5   | ms   |
| t <sub>PU</sub>      | Power-up Delay to Valid Temperature Recording |      | 100 | ms   |

### Temperature Characteristics of Temperature Sensor

V<sub>CC</sub> = 3.3 V ± 10%, T<sub>A</sub> = -40°C to +125°C

| Parameter                                              | Test Conditions/Comments                       | Max    | Unit |
|--------------------------------------------------------|------------------------------------------------|--------|------|
| Temperature Reading Error<br>Class B, JC42.4 compliant | +75°C ≤ T <sub>A</sub> ≤ +95°C, active range   | ±1.0   | °C   |
|                                                        | +40°C ≤ T <sub>A</sub> ≤ +125°C, monitor range | ±2.0   | °C   |
|                                                        | -40°C ≤ T <sub>A</sub> ≤ +125°C, sensing range | ±3.0   | °C   |
| ADC Resolution                                         |                                                | 12     | Bits |
| Temperature Resolution                                 |                                                | 0.0625 | °C   |
| Conversion Time                                        |                                                | 100    | Ms   |
| Thermal Resistance <sup>1</sup> θ <sub>JA</sub>        | Junction-to-Ambient (Still Air)                | 92     | °C/W |

<sup>1</sup> Power Dissipation is defined as P<sub>J</sub> = (T<sub>J</sub> - T<sub>A</sub>)/θ<sub>JA</sub>, where T<sub>J</sub> is the junction temperature and T<sub>A</sub> is the ambient temperature. The thermal resistance value refers to the case of a package being used on a standard 2-layer PCB.

### Slave Address Bits of Temperature Sensor

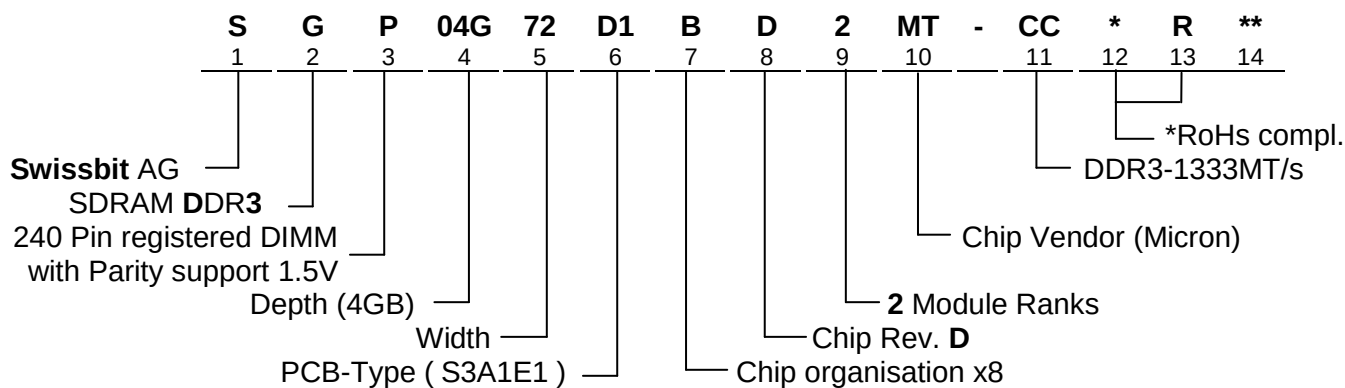
| Device       | Device Type Identifier |    |    |    | Select Address Signals |                |                | R/W# |
|--------------|------------------------|----|----|----|------------------------|----------------|----------------|------|
|              | b7 <sup>1</sup>        | b6 | b5 | b4 | b3                     | b2             | b1             | b0   |
| EEPROM       | 1                      | 0  | 1  | 0  | A <sub>2</sub>         | A <sub>1</sub> | A <sub>0</sub> | R/W# |
| Temp. Sensor | 0                      | 0  | 1  | 1  | A <sub>2</sub>         | A <sub>1</sub> | A <sub>0</sub> | R/W# |

<sup>1</sup> The most significant bit, b7, is sent first.

| Byte | Byte Description                                                | 10600-999 | 8500-777 |
|------|-----------------------------------------------------------------|-----------|----------|
| 0    | CRC RANGE, EEPROM BYTES, BYTES USED                             | 0x92      |          |
| 1    | SPD REVISION                                                    | 0x10      |          |
| 2    | DRAM DEVICE TYPE                                                | 0x0B      |          |
| 3    | MODULE TYPE (FORM FACTOR)                                       | 0x01      |          |
| 4    | SDRAM DEVICE DENSITY & BANKS                                    | 0x03      |          |
| 5    | SDRAM DEVICE ROW & COLUMN COUNT                                 | 0x19      |          |
| 6    | BYTE 6 RESERVED                                                 | 0x00      |          |
| 7    | MODULE RANKS & DEVICE DQ COUNT                                  | 0x09      |          |
| 8    | ECC TAG & MODULE MEMORY BUS WIDTH                               | 0x0B      |          |
| 9    | FINE TIMEBASE DIVIDEND/DIVISOR                                  | 0x52      |          |
| 10   | MEDIUM TIMEBASE DIVIDEND                                        | 0x01      |          |
| 11   | MEDIUM TIMEBASE DIVISOR                                         | 0x08      |          |
| 12   | MIN SDRAM CYCLE TIME (tCK <sub>MIN</sub> )                      | 0x0C      | 0x0F     |
| 13   | BYTE 13 RESERVED                                                | 0x00      |          |
| 14   | CAS LATENCIES SUPPORTED (CL4 => CL11)                           | 0x7E      | 0x1E     |
| 15   | CAS LATENCIES SUPPORTED (CL12 => CL18)                          | 0x00      |          |
| 16   | MIN CAS LATENCY TIME (tAA <sub>MIN</sub> )                      | 0x69      |          |
| 17   | MIN WRITE RECOVERY TIME (tWR <sub>MIN</sub> )                   | 0x78      |          |
| 18   | MIN RAS# TO CAS# DELAY (tRCD <sub>MIN</sub> )                   | 0x69      |          |
| 19   | MIN ROW ACTIVE TO ROW ACTIVE DELAY (tRRD <sub>MIN</sub> )       | 0x30      | 0x3C     |
| 20   | MIN ROW PRECHARGE DELAY (tRP <sub>MIN</sub> )                   | 0x69      |          |
| 21   | UPPER NIBBLE FOR tRAS & tRC                                     | 0x11      |          |
| 22   | MIN ACTIVE TO PRECHARGE DELAY (tRAS <sub>MIN</sub> )            | 0x20      | 0x2C     |
| 23   | MIN ACTIVE TO ACTIVE/REFRESH DELAY (tRC <sub>MIN</sub> )        | 0x89      | 0x95     |
| 24   | MIN REFRESH RECOVERY DELAY (tRFC <sub>MIN</sub> ) LSB           | 0x00      |          |
| 25   | MIN REFRESH RECOVERY DELAY (tRFC <sub>MIN</sub> ) MSB           | 0x05      |          |
| 26   | MIN INTERNAL WRITE TO READ CMD DELAY (tWTR <sub>MIN</sub> )     | 0x3C      |          |
| 27   | MIN INTERNAL READ TO PRECHARGE CMD DELAY (tRTP <sub>MIN</sub> ) | 0x3C      |          |
| 28   | MIN FOUR ACTIVE WINDOW DELAY (tFAW <sub>MIN</sub> ) MSB         | 0x00      | 0x01     |
| 29   | MIN FOUR ACTIVE WINDOW DELAY (tFAW <sub>MIN</sub> ) LSB         | 0xF0      | 0x2C     |
| 30   | SDRAM DEVICE OUTPUT DRIVERS SUPPORTED                           | 0x82      |          |
| 31   | SDRAM DEVICE THERMAL & REFRESH OPTIONS                          | 0x05      |          |

| Byte    | Byte Description                                                    | 10600-999                                 | 8500-777 |
|---------|---------------------------------------------------------------------|-------------------------------------------|----------|
| 32      | DDR3-MODULE THERMAL SENSOR                                          | 0x80                                      |          |
| 33-59   | BYTES 33-59 RESERVED                                                | 0x00                                      |          |
| 60      | MODULE HEIGHT (NOMINAL)                                             | 0x03                                      |          |
| 61      | MODULE THICKNESS (MAX)                                              | 0x11                                      |          |
| 62      | REFERENCE RAW CARD ID                                               | 0x0A                                      |          |
| 63      | ADDRESS MAPPING EDGE CONECTOR TO DRAM                               | 0x05                                      |          |
| 64      | RDIMM THERMAL HEAT SPREADER SOLUTION                                | 0x00                                      |          |
| 65      | REGISTER MFR ID (LSB)                                               | 0x04                                      |          |
| 66      | REGISTER MFR ID (MSB)                                               | 0xB3                                      |          |
| 67      | REGISTER REVISION NUMBER                                            | 0x03                                      |          |
| 68      | REGISTER TYPE                                                       | 0x00                                      |          |
| 69      | RC1 (MS NIBBLE) / RC0 (LS NIBBLE) - RESERVED                        | 0x00                                      |          |
| 70      | RC3 (MS NIBBLE) / RC2 (LS NIBBLE) – DRIVE STRENGTH, COMMAND/ADDRESS | 0x50                                      |          |
| 71-116  | BYTES 71-116 RESEVED                                                | 0x00                                      |          |
| 117     | MODULE MFR ID (LSB)                                                 | 0x83                                      |          |
| 118     | MODULE MFR ID (MSB)                                                 | 0xDA                                      |          |
| 119     | MODULE MFR LOCATION ID                                              | 0x01 Swizerland   0x02 Germany   0x03 USA |          |
| 120     | MODULE MFR YEAR                                                     | X                                         |          |
| 121     | MODULE MFR WEEK                                                     | X                                         |          |
| 122-125 | MODULE SERIAL NUMBER                                                | X                                         |          |
| 126-127 | CRC                                                                 | 0xEEDD                                    | 0x4D75   |
| 128-145 | MODULE PART NUMBER                                                  | "SGP04G72D1BD2MT-xx"                      |          |
| 146     | MODULE DIE REV                                                      | 0x52                                      |          |
| 147     | MODULE PCB REV                                                      | 0x54                                      |          |
| 148     | DRAM DEVICE MFR ID (LSB)                                            | 0x80                                      |          |
| 149     | DRAM DEVICE MFR (MSB)                                               | 0x2C                                      |          |
| 150-175 | MFR RESERVED BYTES 150-175                                          | 0x00                                      |          |
| 176-255 | CUSTOMER RESERVED BYTES 176-255                                     | 0xff                                      |          |

## Part Number Code



\* optional / additional information

\*\* T = thermal sensor

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